

April 1988 Revised October 2000

74F521

8-Bit Identity Comparator

General Description

The 74F521 is an expandable 8-bit comparator. It compares two words of up to eight bits each and provides a LOW output when the two words match bit for bit. The expansion input $\overline{I}_{A=B}$ also serves as an active LOW enable input.

Features

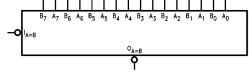
- Compares two 8-bit words in 6.5 ns typ
- Expandable to any word length
- 20-pin package

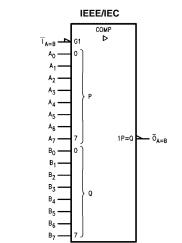
Ordering Code:

Order Number	Package Number	Package Description				
74F521SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide				
74F521SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide				
74F521MSA	MSA20	20-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide				
74F521PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide				

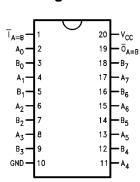
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbols





Connection Diagram



Unit Loading/Fan Out

Pin Names	Do contestion	U.L.	Input I _{IH} /I _{IL}	
	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
A ₀ -A ₇	Word A Inputs	1.0/1.0	20 μA/-0.6 mA	
B ₀ -B ₇	Word B Inputs	1.0/1.0	20 μA/–0.6 mA	
$\bar{I}_{A=B}$	Expansion or Enable Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA	
$\overline{O}_{A=B}$	Identity Output (Active LOW)	50/33.3	−1 mA/20 mA	

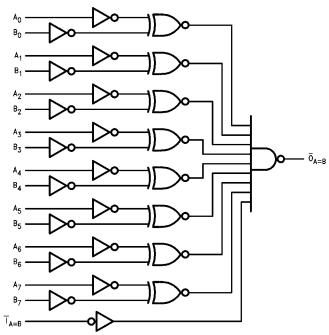
Truth Table

İr	Output			
Ī _{A = B}	$\bar{I}_{A=B}$ A, B			
L	A = B (Note 1)	L		
L	$A \neq B$	Н		
Н	A = B (Note 1)	Н		
н	$A \neq B$	Н		

H = HIGH Voltage Level L = LOW Voltage Level

Note 1: $A_0 = B_0$, $A_1 = B_1$, $A_2 = B_2$, etc.

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Absolute Maximum Ratings(Note 2)

-65°C to +150°C Storage Temperature Ambient Temperature under Bias -55°C to +125°C

Junction Temperature under Bias -55°C to +150°C

V_{CC} Pin Potential to Ground Pin -0.5V to +7.0VInput Voltage (Note 3) -0.5V to +7.0VInput Current (Note 3) -30 mA to +5.0 mA

Voltage Applied to Output

in HIGH State (with $V_{CC} = 0V$)

Standard Output -0.5V to V_{CC}

3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated I_{OL} (mA)

Recommended Operating Conditions

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

Note 2: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 3: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

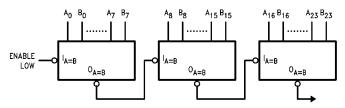
Symbol	Parameter	Min	Тур	Max	Units	V _{CC}	Conditions	
V _{IH}	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal	
V _{IL}	Input LOW Voltage			0.8	V		Recognized as a LOW Signal	
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = -18 mA	
V _{OH}	Output HIGH 10% V _{CC}	2.5			V	Min	I _{OH} = -1 mA	
	Voltage 5% V _{CC}	2.7			V		$I_{OH} = -1 \text{ mA}$	
V _{OL}	Output LOW 10% V _{CC}			0.5	V	Min	1 20 m A	
	Voltage				V	Min	I _{OL} = 20 mA	
I _{IH}	Input HIGH Current			5.0	μΑ	Max	$V_{IN} = 2.7V$	
I _{BVI}	Input HIGH Current			7.0	μА	Max	V 7.0V	
	Breakdown Test						V _{IN} = 7.0V	
I _{CEX}	Output HIGH			50		Max	V V	
	Leakage Current			30	μΑ	IVIAX	$V_{OUT} = V_{CC}$	
V _{ID}	Input Leakage	4.75				V 0.0	$I_{ID} = 1.9 \mu A$	
	Test	4.75			· ·		All Other Pins Grounded	
I _{OD}	Output Leakage			3.75	μА	0.0	V _{IOD} = 150 mV	
	Circuit Current						All Other Pins Grounded	
I _{IL}	Input LOW Current			-0.6	mA	Max	$V_{IN} = 0.5V$	
Ios	Output Short-Circuit Current	-60		-150	mA	Max	V _{OUT} = 0V	
I _{CCH}	Power Supply Current		21	32	mA	Max	V _O = HIGH	

AC Electrical Characteristics

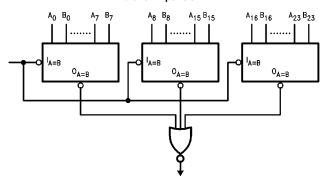
Symbol	Parameter	$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_{A} = -55^{\circ}C \text{ to } +125^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		$T_{A} = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$		Units
		Min	Тур	Max	Min	Max	Min	Max	
t _{PLH}	Propagation Delay	3.0	7.0	10.0	3.0	14.0	3.0	11.0	ns
t _{PHL}	A_n or B_n to $\overline{O}_{A=B}$	4.5	7.0	10.0	4.0	15.0	4.0	11.0	
t _{PLH}	Propagation Delay	3.0	5.0	6.5	3.0	8.5	3.0	7.5	20
t _{PHL}	$\overline{I}_{A=B}$ to $\overline{O}_{A=B}$	3.5	6.5	9.0	3.5	13.5	3.5	10.0	ns

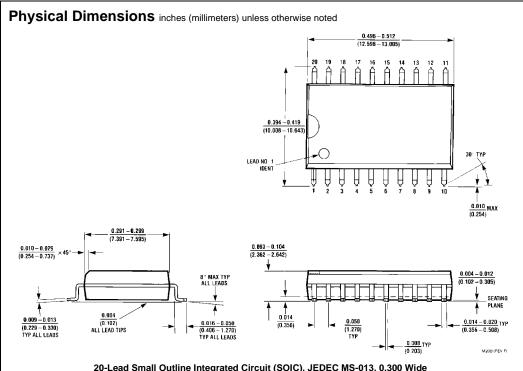
Applications

Ripple Expansion

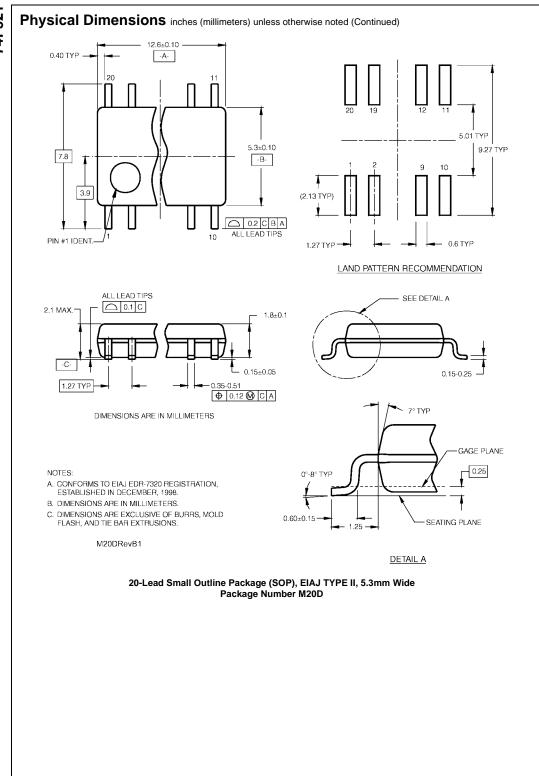


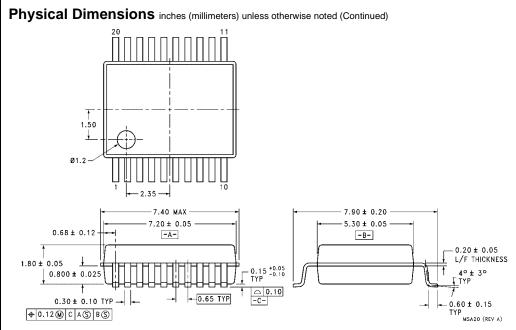
Parallel Expansion



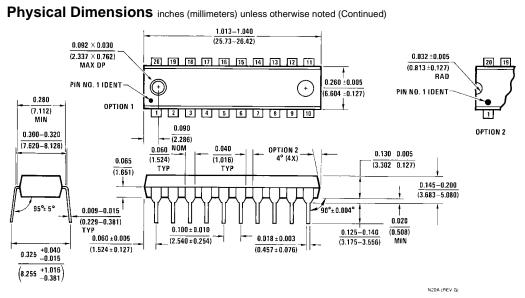


20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide Package Number M20B





20-Lead Shrink Small Outline Package (SSOP), EIAJ TYPE II, 5.3mm Wide Package Number MSA20



20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com